

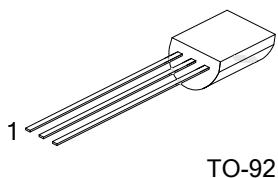
1N60-HC

Power MOSFET

1A, 600V N-CHANNEL POWER MOSFET

■ DESCRIPTION

The UTC 1N60-HC is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

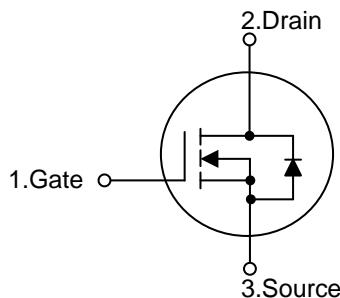


TO-92

■ FEATURES

- * $R_{DS(ON)} \leq 7.5\Omega$ @ $V_{GS}=10V$, $I_D=0.5A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

■ SYMBOL



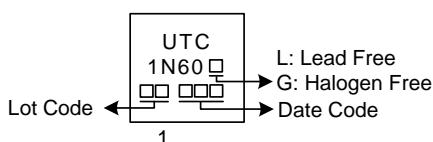
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
1N60L-T92-B	1N60G-T92-B	TO-92	G	D	S	Tape Box
1N60L-T92-K	1N60G-T92-K	TO-92	G	D	S	Bulk

Note: Pin Assignment: G: Gate D: Drain S: Source

1N60G-T92-B 	(2)Package Type	(2) T92: TO-92
	(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ **ABSOLUTE MAXIMUM RATINGS** ($T_C=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	600	V
Gate-Source Voltage	V_{GSS}	± 30	V
Continuous Drain Current	I_D	1	A
Pulsed Drain Current (Note 2)	I_{DM}	2	A
Avalanche Energy (Note 3) Single Pulsed	E_{AS}	48.6	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2.3	V/ns
Power Dissipation	P_D	1.4	W
Junction Temperature	T_J	+150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ\text{C}$

- Notes:
1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 3. $L=30\text{mH}$, $I_{AS}=1.8\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\ \Omega$, Starting $T_J = 25^\circ\text{C}$
 4. $I_{SD} \leq 1.0\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ **THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	180	$^\circ\text{C/W}$
Junction to Case	θ_{JC}	80	$^\circ\text{C/W}$

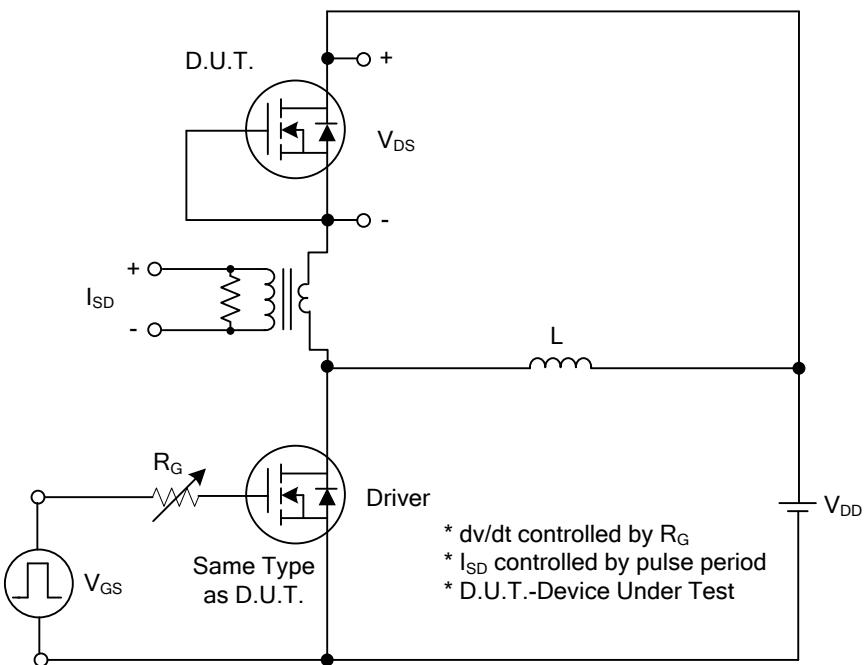
■ ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$	600			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}} = 600\text{V}, V_{\text{GS}} = 0\text{V}$		10		μA
Gate-Source Leakage Current	Forward	$V_{\text{GS}} = 30\text{V}, V_{\text{DS}} = 0\text{V}$		100		nA
	Reverse	$V_{\text{GS}} = -30\text{V}, V_{\text{DS}} = 0\text{V}$		-100		nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 0.5\text{A}$			7.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{\text{DS}} = 25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$		149		pF
Output Capacitance	C_{OSS}			30		pF
Reverse Transfer Capacitance	C_{RSS}			6.6		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge	Q_G	$V_{\text{DS}} = 480\text{V}, V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 1\text{A}, I_{\text{G}} = 1\text{mA}$ (Note 1, 2)		12		nC
Gate-Source Charge	Q_{GS}			3.8		nC
Gate-Drain Charge	Q_{GD}			3		nC
Turn-On Delay Time	$t_{\text{D(ON)}}$	$V_{\text{DD}} = 100\text{V}, V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 1\text{A}, R_{\text{G}} = 25\Omega$ (Note 1, 2)		4		ns
Turn-On Rise Time	t_R			15		ns
Turn-Off Delay Time	$t_{\text{D(OFF)}}$			33		ns
Turn-Off Fall Time	t_F			37		ns
DRAIN-SOURCE DIODE CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				1	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SD}				2	A
Drain-Source Diode Forward Voltage	V_{SD}	$I_S = 1.0\text{A}, V_{\text{GS}} = 0\text{V}$			1.4	V
Reverse Recovery Time	t_{rr}	$I_F = 1.0\text{A}, V_{\text{DD}} = 400\text{V}$ $dI/dt = 100\text{A}/\mu\text{s}$		192		ns
Reverse Recovery Charge	Q_{rr}			0.65		μC

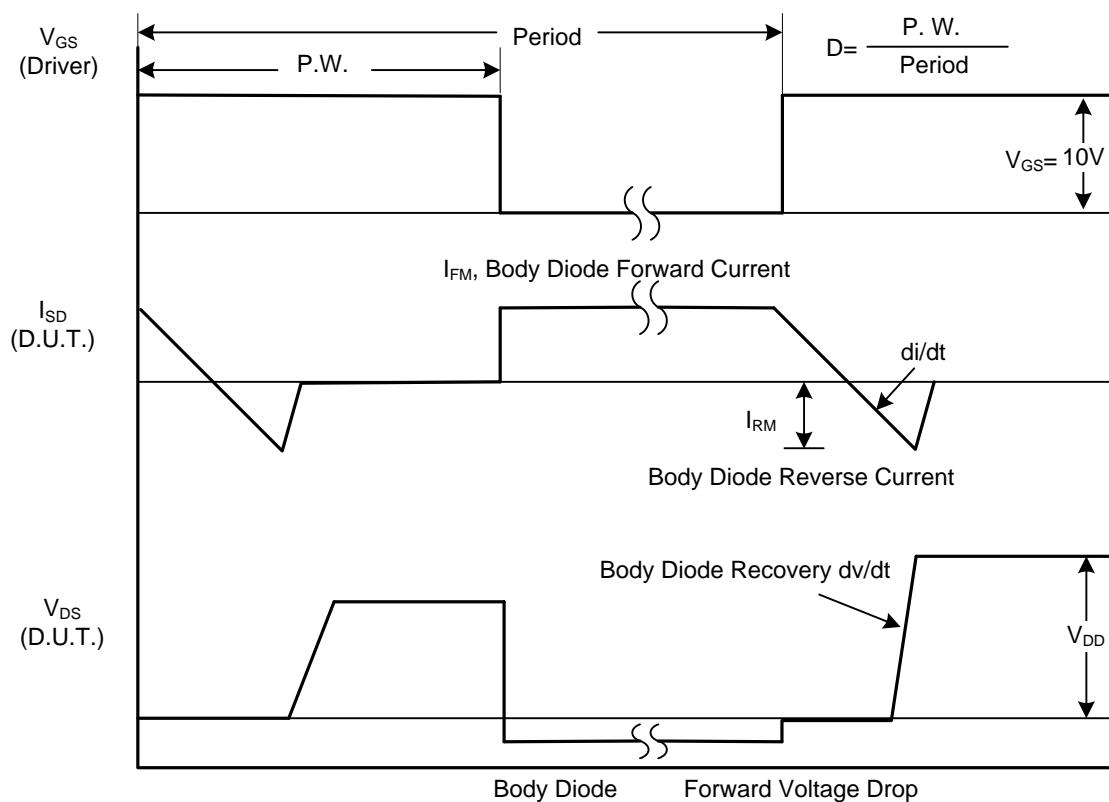
Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

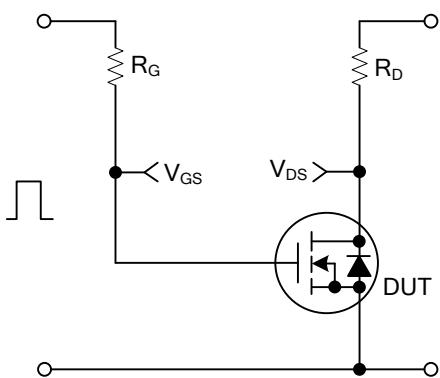


Peak Diode Recovery dv/dt Test Circuit

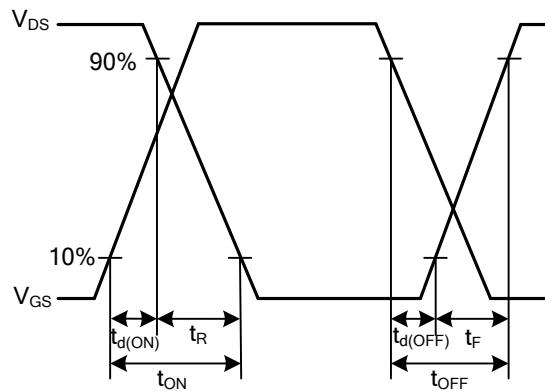


Peak Diode Recovery dv/dt Waveforms

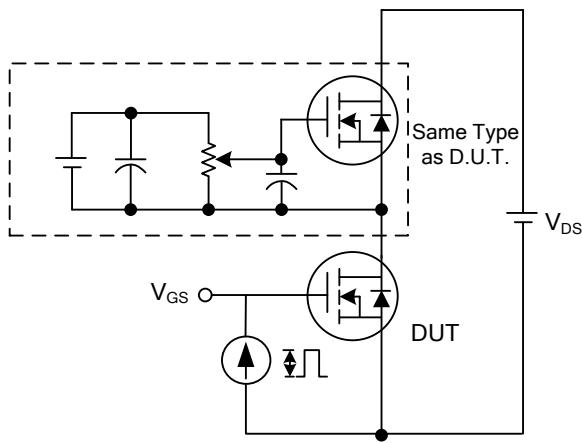
■ TEST CIRCUITS AND WAVEFORMS



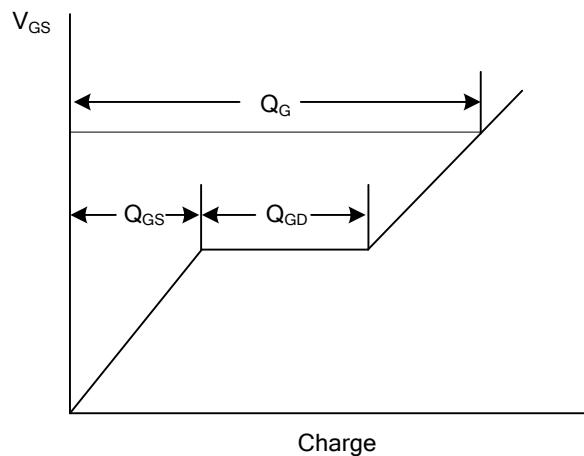
Ricing Test Circuit



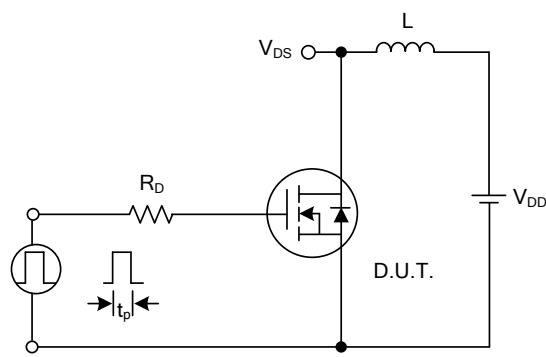
Switching Waveforms



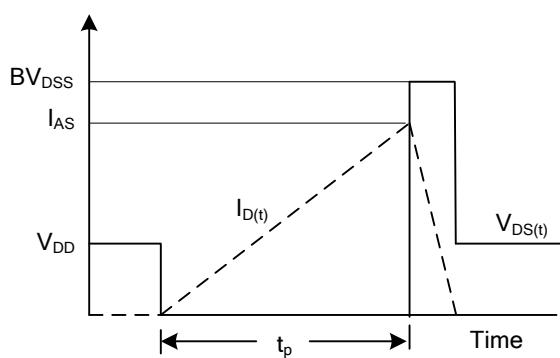
Gate Charge Test Circuit



Gate Charge Waveform

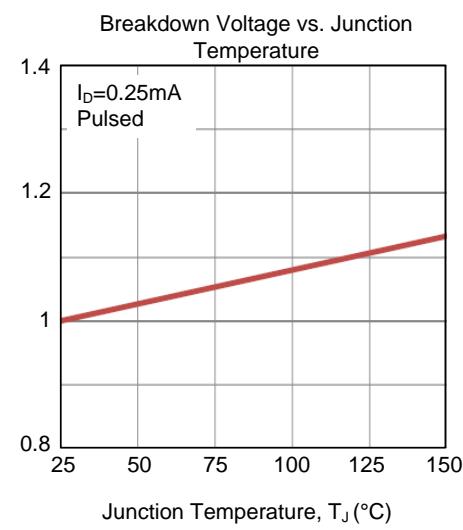
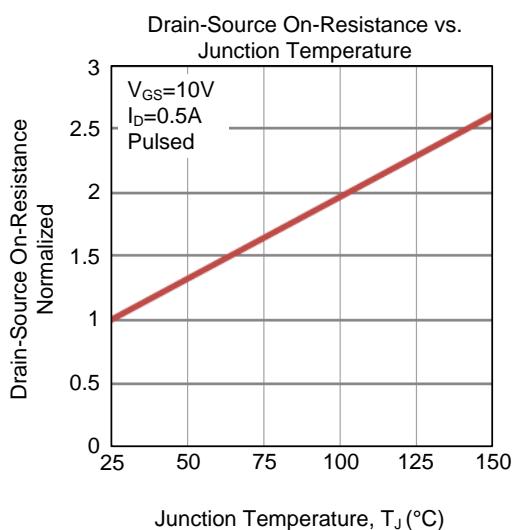
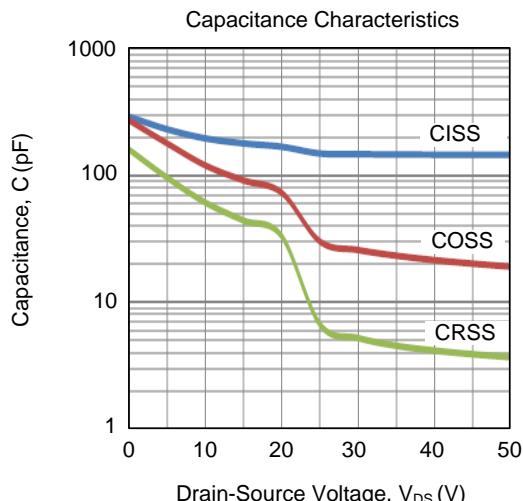
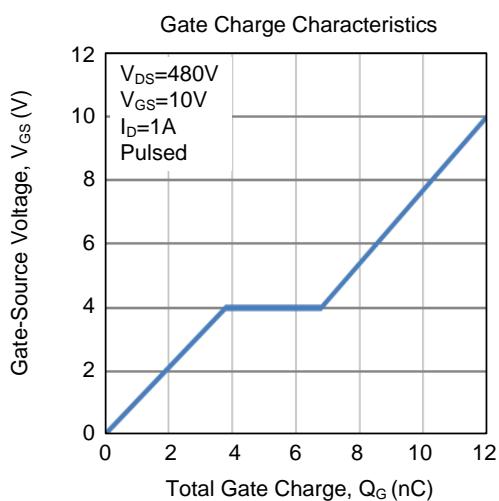
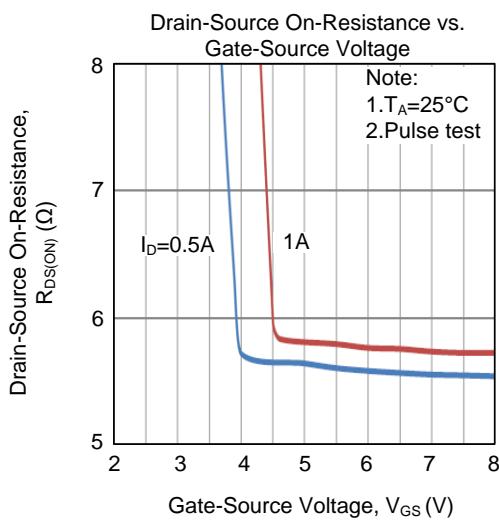
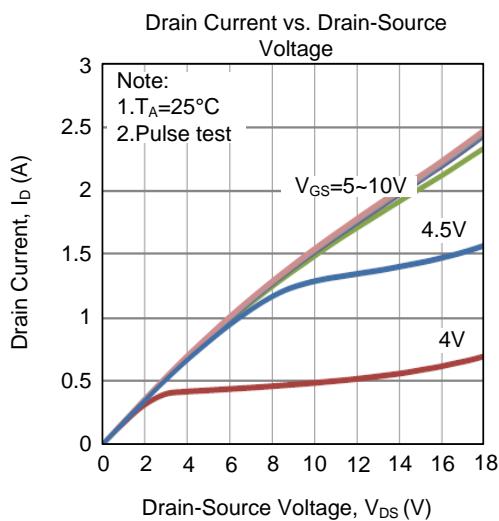


Unclamped Inductive Switching Test Circuit

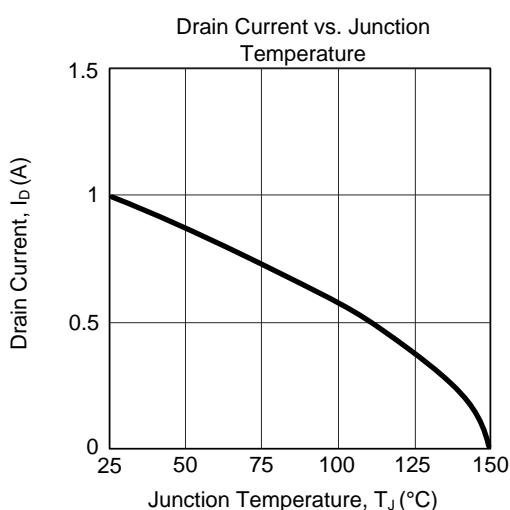
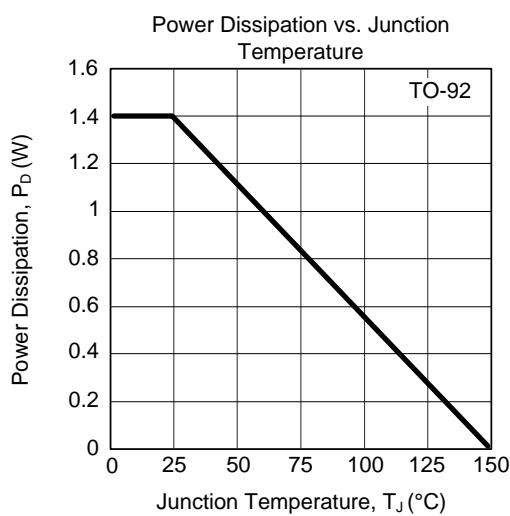
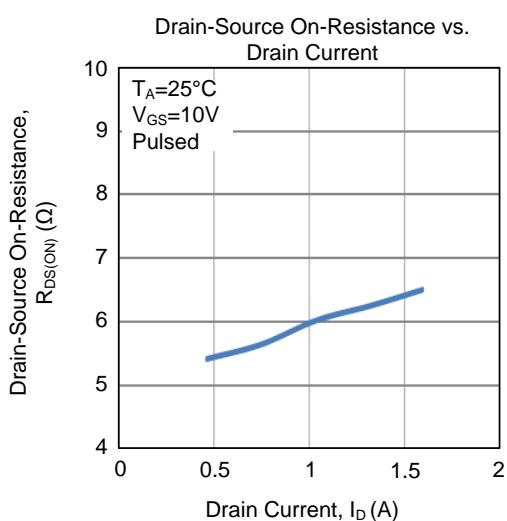
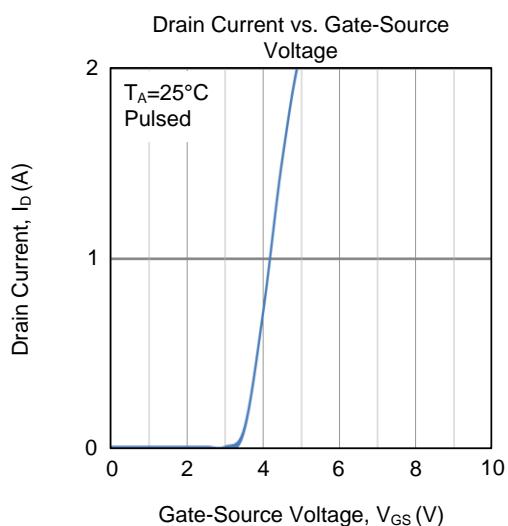
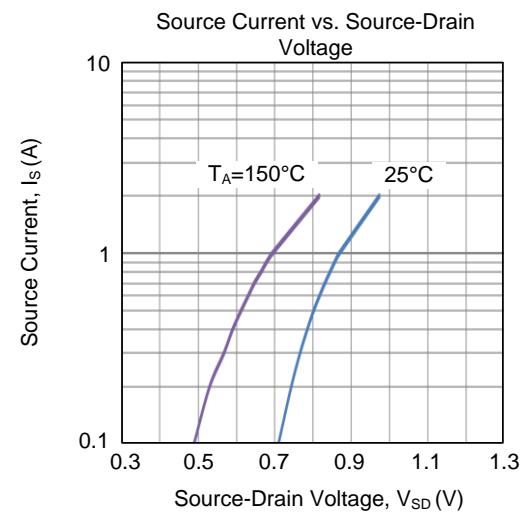
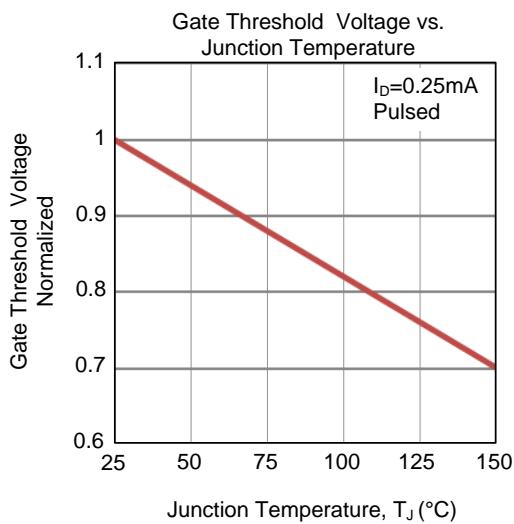


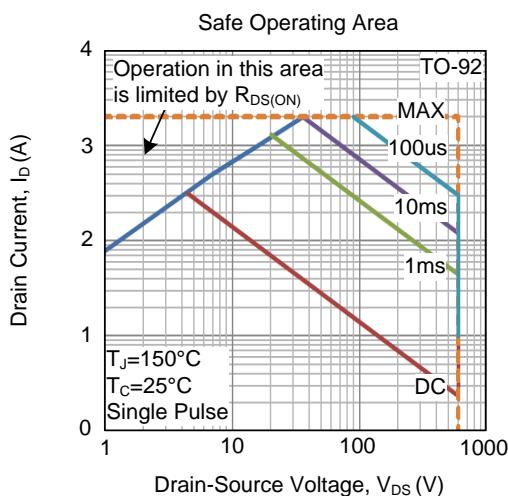
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)

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